

SEMICONDUCTOR®

# **KSE200**

## Feature

- Low Collector-Emitter Saturation Voltage
- High Current Gain Bandwidth Product : f<sub>T</sub>=65MHz @ I<sub>C</sub>=100mA (Min.)
- Complement to KSE210



# **NPN Epitaxial Silicon Transistor**

## Absolute Maximum Ratings T<sub>C</sub>=25°C unless otherwise noted

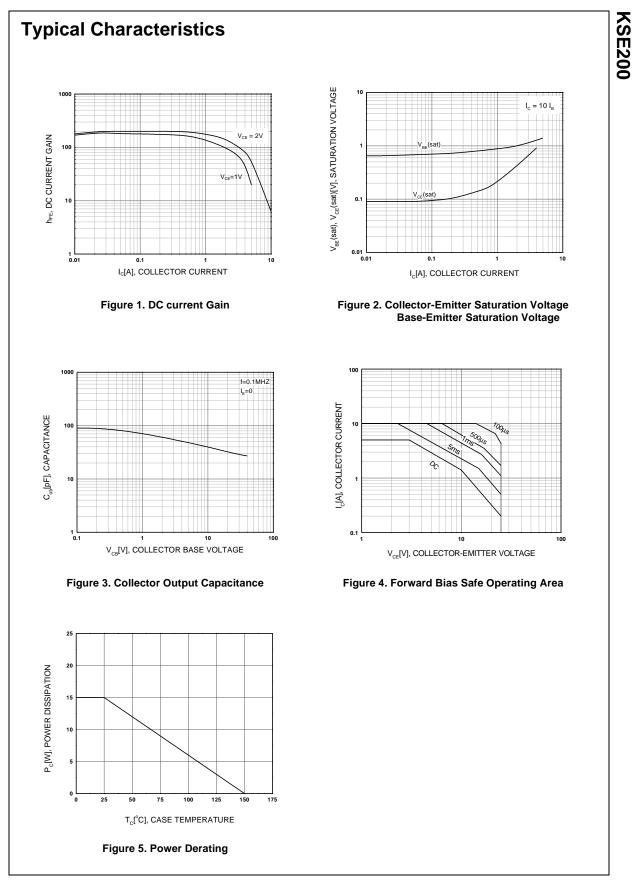
Symbol	Parameter	Value	Units
V <sub>CBO</sub>	Collector-Base Voltage	40	V
V <sub>CEO</sub>	Collector-Emitter Voltage	25	V
V <sub>EBO</sub>	Emitter- Base Voltage	8	V
I <sub>C</sub>	Collector Current	5	A
P <sub>C</sub>	Collector Dissipation (T <sub>C</sub> =25°C)	15	W
Tj	Junction Temperature	150	°C
T <sub>STG</sub>	Storage Temperature	- 65 ~ 150	°C

# Electrical Characteristics T<sub>C</sub>=25°C unless otherwise noted

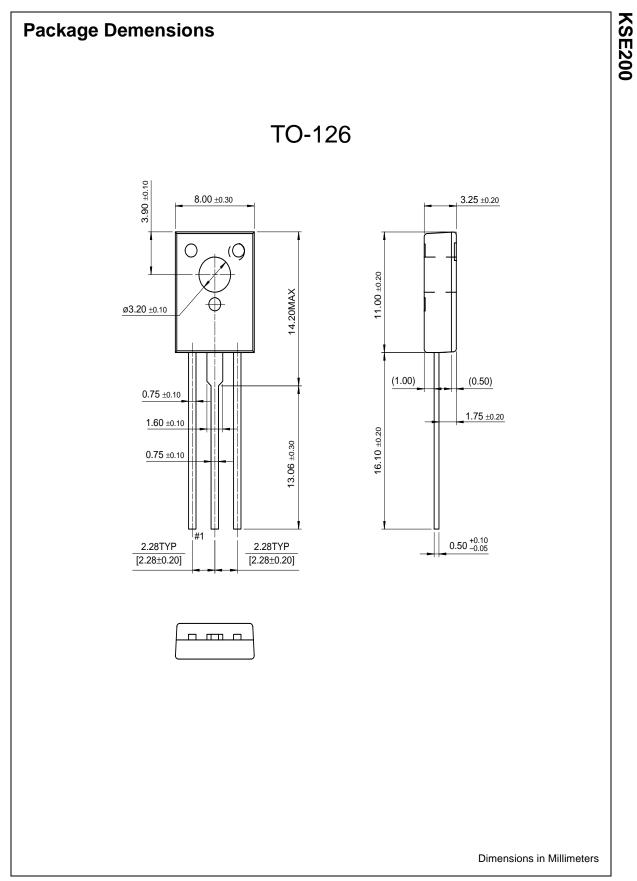
Symbol	Parameter	Test Condition	Min.	Max.	Units
BV <sub>CEO</sub>	Collector-Emitter Breakdown Voltage	I <sub>C</sub> =10mA, I <sub>B</sub> =0	25		V
I <sub>CBO</sub>	Collector Cut-off Current	V <sub>CB</sub> =40V, I <sub>E</sub> =0		100	nA
		V <sub>CB</sub> =40V, I <sub>E</sub> =0 @ T <sub>J</sub> =125°C		100	μΑ
I <sub>EBO</sub>	Emitter Cut-off Current	V <sub>BE</sub> =8V, I <sub>C</sub> =0		100	nA
h <sub>FE</sub>	DC Current Gain	V <sub>CE</sub> =1V, I <sub>C</sub> =500mA	70		
		V <sub>CE</sub> =1V, I <sub>C</sub> =2A	45	180	
		V <sub>CE</sub> =2V, I <sub>C</sub> =5A	10		
V <sub>CE</sub> (sat)	Collector-Emitter Saturation Voltage	I <sub>C</sub> =500mA, I <sub>B</sub> =50mA		0.3	V
		I <sub>C</sub> =2A, I <sub>C</sub> =200mA		0.75	V
		I <sub>C</sub> =5A, I <sub>B</sub> =1A		1.8	V
V <sub>BE</sub> (sat)	Base- Emitter Saturation Voltage	I <sub>C</sub> =5A, I <sub>B</sub> =1A		2.5	V
V <sub>BE</sub> (on)	Base-Emitter On Voltage	V <sub>CE</sub> =1V, I <sub>C</sub> =2A		1.6	V
f <sub>T</sub>	Current Gain Bandwidth Product	V <sub>CE</sub> =10V, I <sub>C</sub> =100mA	65		MHz
C <sub>ob</sub>	Output Capacitance	V <sub>CB</sub> =10V, I <sub>E</sub> =0, f=0.1MHz		80	pF

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